

**Search Notes**

Application/Control No.

10/820,523

Examiner

Phallaka Kik

Applicant(s)/Patent under  
Reexamination

KAWA ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	17,18,16, 3,2	3/19/2006	PK
Above	updated	4/12/2006	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	17,18,16	4/12/2006	PK
716	3,2	4/12/2006	PK
--USPGPUB (see attached)		4/12/2006	PK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/sub searched: 716/1-18 (see attached)	3/19/2006	PK
Above updated (see attached)	4/12/2006	PK
IEE/IEEE Xplore (see attached)	3/19/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	3/19/2006	PK